Notice of References Cited Application/Control No. 10/784,606 Examiner Jacques M. Saint-Surin Applicant(s)/Patent Under Reexamination DIMEO ET AL. Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2005/0103097	05-2005	Faltum et al.	073/061.41
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